



## **SECTION 19**

### **CDR MoneT FLASH EEPROM**

#### **19.1 Introduction**

The two CDR MoneT flash EEPROM modules (CMF) serve as electrically programmable and erasable non-volatile memory (NVM) to store system program and data. The modules are designed to be used with the unified bus (U-bus). The CMF arrays use Motorola's one-transistor (MoneT) bit cell technology. The MPC555 / MPC556's total 448-Kbytes of flash EEPROM non-volatile memory are distributed between two CMF EEPROM modules: a 256-Kbyte array and a 192-Kbyte array. The erase block size is 32 Kbytes.

Each CMF EEPROM module is arranged into two major sections. The first section is the flash EEPROM array used to store system program and data. The second section is the bus interface unit (BIU) that controls access and operation of the array through a standard U-bus interface and the external signals EPEE (external program or erase enable) and VPP (supply program or erase power).

Each CMF EEPROM module array is divided into blocks to allow for independent erase, access state, and protection from program and erase for each block. Information is transferred to the CMF EEPROM through the U-bus a word (32 bits), half-word (16 bits), or byte at a time.

The BIU accesses 32 bytes of information in the array at a time. These bytes are copied into a read-page buffer aligned to the low order addresses, ADDR[27:31]. Each CMF module contains two non-overlapping page buffers. The first page buffer is associated with array blocks zero to three. The second page is associated with array blocks four to seven (for CMF Module A), or blocks four to five (for CMF Module B).

Read access time for data in the page buffers (on-page read) is one system clock. The read access time for a new page of data (off-page read) is two system clocks. To prevent the BIU from accessing an unnecessary page from the array, the CMF EEPROM monitors the U-bus address to determine whether the required information is in one of the two current pages and whether the access is valid for the module.

Burst accesses are not supported by the CMF EEPROM. In normal operation, write accesses to the CMF array are not recognized.

The CMF EEPROM module requires an external program or erase voltage (VPP) to program or erase the array or any of its control register shadow bits. Special hardware interlocks and the external signal EPEE protect the array from accidental enabling of program and erase operation. The program and erase algorithms are implemented by a series of writes to the CMF EEPROM registers and are under software control.

Up to eight unique 64-byte pages are programmed simultaneously in eight separate array blocks of each of the two CMF modules. Each of the pages being programmed simultaneously is located at the same block offset address, ADDR[17:25].



Erasing is performed on one or more of the selected block(s) simultaneously.

### 19.1.1 MPC555 / MPC556 CMF Features

- Motorola's one-transistor (MoneT) bit cell
- Reset configuration stored in special FLASH NVM locations
- Array sizes of 256 Kbytes and 192 Kbytes
- Arrays distributed in 32-Kbyte blocks
  - Erase by block(s)
  - Block protection for program and erase operations
  - Block access state control
    - Select between supervisor and supervisor/user spaces
    - Select between data and instruction/data spaces
  - 32-bit word length
- Page mode read
  - Retains two separate pages per CMF module
  - Page size of 32 bytes (eight words)
  - Off-page read access time of two system clocks
  - On-page read access time of one system clock
- Supports U-bus pipelined accesses to a pipe depth of two
- Program up to 512 bytes at a time per CMF module
  - Program up to eight unique 64-byte pages of data in eight separate blocks simultaneously (CMF Module A)
  - Program up to six unique 64-byte pages of data in six separate blocks simultaneously (CMF Module B)
  - Program CMF Module A and CMF Module B at the same time
  - Pages located at the same offset address
- Self-timed program and erase pulses
  - Internal pulse width timing control generates pulses from 4.00  $\mu$ s to 2.73 s using system clock frequencies from 8.0 MHz to 40.0 MHz
- Censored access mode with a user bypass for uncensored access per CMF module
- External 4.75 to 5.25-V VPP program and erase power supply
- External program or erase enable signal (EPEE)
- CMF arrays are hardware mapped to the first 512 Kbytes of the 4-Mbyte internal address space of the U-bus
- Supports external emulation

### 19.1.2 Glossary of Terms for the CMF EEPROM

- **Array block** — 32-Kbyte contiguous block of information. Each array block may be erased independently.
- **BIU** — Bus interface unit controls access and operation of the CMF array through a standard U-bus interface.
- **Cleared censorship** — CENSOR[0:1] = 00. The CMF EEPROM can change to

either no censorship or information censorship without modifying the CMF array contents. Cleared censorship will prevent CMF array accesses when the device is censored and ACCESS = 0.

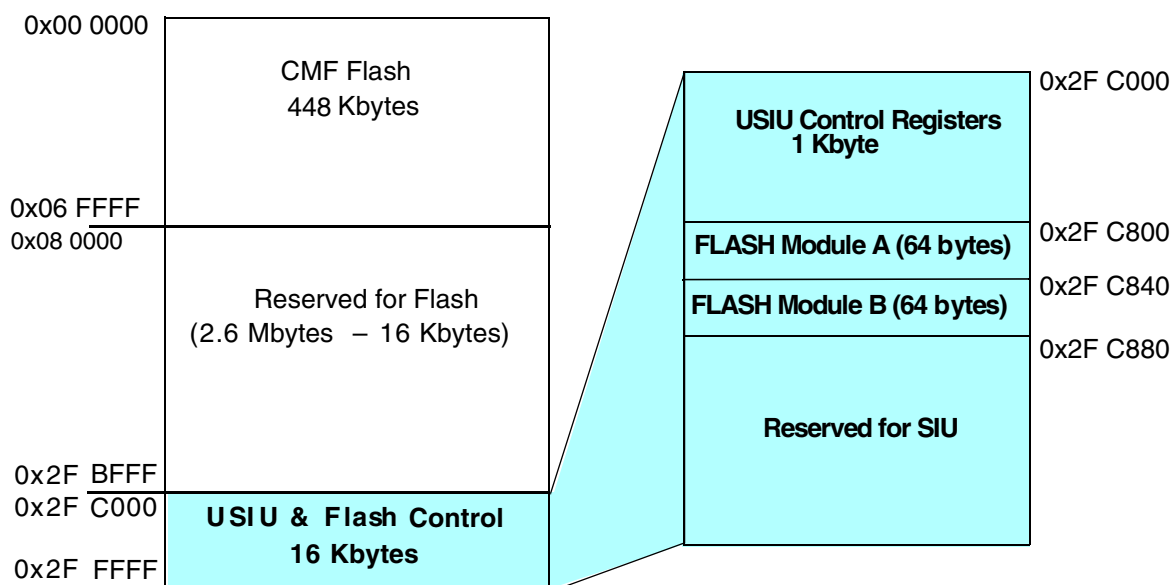


- **Erase interlock write** — A write to any CMF array address after initializing the erase sequence.
- **Erase margin read** — Special off-page read of the CMF array where the CMF EEPROM hardware adjusts the reference of the sense amplifier to check for correct erase operation. All CMF array off-page read accesses between the erase interlock write and clearing the SES bit are erase margin reads.
- **Information censorship** — CENSOR[0:1] = 11. Requires an erase of the CMF EEPROM to change CENSOR[0:1]. Information censorship will prevent CMF array accesses when the device is censored and ACCESS = 0. Information stored in the CMF array is made invalid while clearing CENSOR[0:1].
- **Initialize program/erase sequence** — The write to the high voltage control register that changes the SES bit from a zero to a one.
- **MoneT** — The CMF EEPROM's FLASH bit cell.
- **No censorship** — CENSOR[0:1] = 10 or 01, The CMF EEPROM can change to information censorship without modifying the CMF array contents. No censorship allows all CMF array accesses.
- **Off-page read** — Array read operation that requires two clocks and updates a page buffer.
- **On-page read** — Array read operation that accesses information in one of the read page buffers and requires one clock.
- **Over-programmed** — By exceeding the specified programming time and/or voltage a CMF bit may be over-programmed. This bit will cause erased bits on the same column in the same array block to read as programmed.
- **Programming write** — A word write to a CMF array address to transfer information into a program page buffer. The CMF EEPROM accepts programming writes from after initializing the program sequence until the EHV bit is changed from a zero to a one.
- **Program margin read** — Special off-page read of the CMF array where the CMF EEPROM hardware adjusts the reference of the sense amplifier to check for correct program operation. All CMF array off-page read accesses between the first programming write and clearing the SES bit are program margin reads.
- **Program page buffer** — 64 bytes of information used to program the CMF array. This information is aligned to a 64-byte boundary within the CMF array block. Each CMF module has one program page buffer for each array block.
- **Read page buffer** — 32-byte block of information that is read from the CMF array. This information is aligned to a 32-byte boundary within the CMF array. Each CMF module has two read page buffers.
- **Shadow information** — An extra row (256 bytes) of the CMF array used to provide reset configuration information. This row may be accessed by setting the SIE bit in the module configuration register and accessing the CMF array. The shadow information is always in the lowest array block of the CMF array.

## 19.2 Programming Model

The CMF EEPROM Module consists of two addressed sections. The first is the 32-byte control registers used to configure, program, erase and test the CMF EEPROM array while, the second is the array.

**Figure 19-1** shows the part of the MPC555 / MPC556 memory map involving the CMF arrays and control registers. Refer to **1.3 MPC555 / MPC556 Address Map** for the complete memory map.



**Figure 19-1 CMF Array and Control Register Addressing**

### 19.2.1 CMF EEPROM Control Registers

The control registers are used to control CMF EEPROM module operation. They reside in supervisor data space. On master reset the registers are loaded with default reset information. Some of the registers are special CMF NVM registers which retain their state when power is removed from the CMF EEPROM. These special FLASH NVM registers are identified in the individual register field and control bit descriptions.

The CMF EEPROM control registers are accessible for read or write operation at all times while the device is powered up except during master reset, soft reset or erase interlock write.

The access time of a CMF register is one system clock for both read and write accesses. Accesses to reserved registers will cause the BIU to generate a data error exception.

**Table 19-1** is a programming model for each set of CMF EEPROM control registers. The address offset is from the start of the control register block for each CMF module. (See **Figure 19-1**.)



**Table 19-1 CMF Register Programmer's Model**

Address	MSB 0	Register	LSB 31
<b>Control Registers (Located in Supervisor Data Space)</b>			
0x2F C800 0x2F C840		CMF Module Configuration Register (CMFMCR) See <b>Table 19-2</b> for bit descriptions.	
0x2F C804 0x2F C844		CMF EEPROM Test Register (CMFTST) See <b>Table 19-3</b> for bit descriptions.	
0x2F C808 0x2F C848		High Voltage Control Register (CMFCTL) See <b>Table 19-6</b> for bit descriptions.	
0x2F C80C — 0x2F C81C 0x2F C84C — 0x2F C85C		Reserved	
<b>CMF Flash Array</b>			
0x00 0000 — 0x03 FFFF		CMF_A RAM Array	
0x04 0000 — 0x06 FFFF		CMF_B RAM Array	

### 19.2.1.1 CMF EEPROM Configuration Register (CMFMCR)

The CMF EEPROM module configuration register is used to control the operation of the CMF EEPROM array and BIU. Two bits (the Censor bits) of the CMFMCR bits are special FLASH NVM registers. The factory default state of the Censor bits is either 0b01 or 0b10.

#### CMFMCR — CMF EEPROM Configuration Register

**0x2F C800**  
**0x2F C840**

MSB 0	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15
LOCK	0	0	FIC	SIE	AC-CESS	CENSOR <sup>1</sup>		SUPV[0:7]							
RESET:															
1	0	0	0	0	0			1	1	1	1	1	1	1	1
16	17	18	19	20	21	22	23	24	25	26	27	28	29	30	LSB 31
DATA[0:7]								PROTECT[0:7]							
RESET:															
0	0	0	0	0	0	0	0	1	1	1	1	1	1	1	1

1. The reset state of bits 6:7 are defined by special FLASH NVM registers. The factory default state is either 0b01 or 0b10.

**Table 19-2 CMFMCR Bit Descriptions**



Bit(s)	Name	Description
0	$\overline{\text{LOCK}}$	<p>Lock control. When the <math>\overline{\text{LOCK}}</math> control bit is cleared, the following bits are locked: FIC, SUPV[0:7], DATA[0:7] and PROTECT[0:7]. Writes to these bits will have no effect.</p> <p>In normal operation, once the <math>\overline{\text{LOCK}}</math> bit is cleared, the write-lock can only be disabled again by a master reset. The <math>\overline{\text{LOCK}}</math> bit is writable if the device is in background debug mode and CSC = 0.</p> <p>0 = Write-locked registers are protected 1 = Write-lock is disabled (reset state)</p> <p><b>Warning:</b> If the lock protection mechanism is enabled (<math>\overline{\text{LOCK}}</math> = 0) before the PROTECT[0:7] bits are cleared, the device must use background debug mode to program or erase the CMF array.</p>
1:2	—	Reserved
3	FIC	<p>Force information censorship for access development. Refer to <a href="#">19.8 Censored and Non-Censored Accesses</a> for details.</p> <p>The FIC bit is write protected by the <math>\overline{\text{LOCK}}</math>. If FIC = 1 it cannot be cleared except by a hard reset.</p> <p>0 = Normal CMF censorship operation 1 = Forces the CMF into information censorship mode, unless ACCESS = 1</p>
4	SIE	<p>Shadow information enable. Refer to <a href="#">19.3 Shadow Information</a> for details.</p> <p>The SIE bit is write protected by the SES bit for programming operation. Writes have no effect if (SES = 1 and PE = 0). The SIE bit can be read whenever the registers are enabled.</p> <p>0 = Normal array access 1 = Disables normal array access and selects the shadow information</p>
5	ACCESS	<p>Enable uncensored access. Refer to <a href="#">19.8 Censored and Non-Censored Accesses</a> for details.</p> <p>Writes to this bit have no effect when CSC = 1. This bit can be set only when the MCU is in uncensored mode.</p> <p>0 = Censored CMF array access allowed only if the CMF censorship is no censorship, (FIC = 0 and CENSOR[0] ≠ CENSOR[1]) 1 = Allows all CMF array access.</p>
6:7	CENSOR	<p>Censor accesses. The value of these bits is determined by the state of two NVM bits in two special NVM fuses. Refer to <a href="#">19.8 Censored and Non-Censored Accesses</a> for details.</p> <p>The default reset state of CENSOR is user defined by the FLASH NVM register bits.</p> <p>00 = Cleared censorship, CMF array access allowed only if device is in uncensored mode or ACCESS = 1 01 = No censorship, All CMF array accesses allowed 10 = No censorship, All CMF array accesses allowed 11 = Information censorship, CMF array access allowed only if device is in uncensored mode or ACCESS = 1</p>
8:15	SUPV[0:7]	<p>Supervisor space. Each array block can be mapped into supervisor or unrestricted address space. When an array block is mapped into supervisor address space, only supervisor accesses are allowed. A user access to a location in supervisor address space will result in a data error exception. When an array block is mapped into unrestricted address space, both supervisor and user accesses are allowed.</p> <p>The SUPV[0:7] bits are write protected by the <math>\overline{\text{LOCK}}</math> and CSC bits. Writes will have no effect if <math>\overline{\text{LOCK}}</math>=0 or CSC=1.</p> <p>0 = Array block M is placed in unrestricted address space 1 = Array block M is placed in supervisor address space (reset value)</p>

**Table 19-2 CMFMCR Bit Descriptions (Continued)**



Bit(s)	Name	Description
16:23	DATA[0:7]	<p>Data space. Each array block can be mapped into data or both data and instruction address space. When an array block is mapped into data address space (DATA[M] = 1) only data accesses are allowed. An instruction access to a location in data address space will result in a data error exception. When an array block is mapped into both data and instruction address space (DATA[M] = 0), both data and instruction accesses are allowed.</p> <p>The DATA[0:7] bits are write protected by the <math>\overline{\text{LOCK}}</math> and CSC bits. Writes have no effect if <math>\overline{\text{LOCK}} = 0</math> or CSC = 1.</p> <p>0 = Array block M is placed in both data and instruction address spaces (reset value) 1 = Array block M is placed in data address space</p>
24:31	PROTECT [0:7]	<p>Block protect. Each array block of the CMF EEPROM can be protected from program and erase operation by setting PROTECT[M] = 1. The CMF BIU will perform all programming and erase interlocks except the program and erase voltages will not be applied to MoneT locations within the protected array block(s).</p> <p>Writes to PROTECT[0:7] have no effect if <math>\overline{\text{LOCK}} = 0</math> or CSC = 1 or SES = 1.</p> <p>0 = Array block M is unprotected 1 = Array block M is protected (default value)</p> <p><b>Warning:</b> If a CMF EEPROM enables the lock protection mechanism (<math>\overline{\text{LOCK}} = 0</math>) before PROTECT is cleared, the device must use background debug mode to program or erase the CMF EEPROM.</p>

### 19.2.1.2 CMF EEPROM Test Register (CMFTST)

The CMF EEPROM test register (CMFTST) is used to control the test operation of the CMF array. Only six bits [20:23, 25:26] are readable or writeable in normal operation.

#### CMFTST — CMF EEPROM Test Register

**0x2F C804**

**0x2F C844**

MSB 0	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15
RESERVED															
RESET:															
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
16	17	18	19	20	21	22	23	24	25	26	27	28	29	30	LSB 31
RESERVED				NVR <sup>1</sup>	PAWS			RE-SERVE D	STE <sup>1,2</sup>	GDB <sup>1</sup>	RESERVED				
RESET:															
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

#### NOTES:

1. The NVR, STE, and GDB bits are not accessible in all revisions of the MPC555 / MPC556 (2K02A mask sets and earlier).
2. The STE bit should always be programmed as a 0.



**Table 19-3 CMFTST Bit Descriptions**



Bit(s)	Name	Description
0:19	—	Reserved
20	NVR	Negative voltage range. This bit switches between the low and high voltage range of the negative charge pump in programming and erasing the CMF Flash module when GDB = 0b1. This bit is writeable when HVS = 0b0. 0 = High Range (more negative) 1 = Low Range
21:23	PAWS [0:2]	Program amplitude/width modulation select. The PAWS bits, in conjunction with the NVR and GDB bits can be used to select the programming voltage applied to the drain or gate of the EE-PROM bitcell. These bits should be left set to 0b000, unless advised by Motorola. For information about PAWS programming modes, see <a href="#">Table 19-4</a> and <a href="#">Table 19-5</a> .
24	—	Reserved
25	STE	This bit is reserved for Motorola factory testing and should always be programmed to 0b0. 0 = Normal Operation 1 = Factory test mode use only. This setting could disturb contents of flash.
26	GDB	Gate/drain bias select. This bit works in conjunction with the PAWS bits to select between positive and negative ramped voltages for programing and erasing. This bit is writeable when SES = 0b0. 0 = Positive voltage ramp selected on the bitcell drain. 1 = Negative voltage ramp selected on the bitcell gate.
27:31	—	Reserved

**Table 19-4 CMF Programming Algorithm (v6 and Later)**

No. of Pulses	Pulse Width	NVR	PAWs	GDB	PAWs Mode	Description
4	256 $\mu$ s	1	100	1	Mode 4NL	Negative gate ramp (low range)
4	256 $\mu$ s	1	101	1	Mode 5NL	
4	256 $\mu$ s	1	110	1	Mode 6NL	
4	256 $\mu$ s	1	111	1	Mode 7NL	
20	50 $\mu$ s	0	100	1	Mode 4NL	Negative gate ramp (high range)
20	50 $\mu$ s	0	101	1	Mode 5NL	
20	50 $\mu$ s	0	110	1	Mode 6NL	
max. 48,000	50 $\mu$ s	0	111	1	Mode 7NL	



**Table 19-5 CMF Erase Algorithm (v6)**



No. of Pulses	Pulse Width	NVR	PAWs	GDB	PAWs Mode	Description
1	100 ms <sup>1</sup>	1	100	1	Mode 4NL	Negative gate ramp (low range)
1	100 ms <sup>1</sup>	1	101	1	Mode 5NL	
1	100 ms <sup>1</sup>	1	110	1	Mode 6NL	
1	100 ms <sup>1</sup>	1	111	1	Mode 7NL	
1	100 ms <sup>1</sup>	0	100	1	Mode 4NL	Negative gate ramp (high range)
1	100 ms <sup>1</sup>	0	101	1	Mode 5NL	
1	100 ms <sup>1</sup>	0	110	1	Mode 6NL	
20	100 ms <sup>2</sup>	0	111	1	Mode 7NL	

**NOTES:**

1. No margin read after pulse.
2. Do margin read after each pulse.

### 19.2.1.3 CMF EEPROM High Voltage Control Register (CMFCTL)

The CMF EEPROM high voltage control register is used to control the program and erase operations of the CMF EEPROM module and setting and clearing CENSOR[0:1] fuses. Refer to [19.7 Voltage Control for Programming and Erasing](#) for more information on this register.

#### CMFCTL — CMF EEPROM High Voltage Control Register

**0x2F C808**  
**0x2F C848**

MSB 0	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15
HVS	0	SCLKR			0	CLKPE		0	CLKPM						
PORESET/HRESET:															
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
SRESET:															
U	U	U	U	U	U	U	U	U	U	U	U	U	U	U	U
16	17	18	19	20	21	22	23	24	25	26	27	28	29	30	LSB 31
BLOCK[0:7]								0	CSC	EPEE	0	0	PE	SES	EHV
PORESET/HRESET:															
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
SRESET:															
U	U	U	U	U	U	U	U	U	U	U	U	U	U	U	U

**Table 19-6 CMFCTL Bit Descriptions**



Bit(s)	Name	Description
0	HVS	High voltage status. During a program or erase pulse this bit is set while the pulse is active or during recovery. The BIU does not acknowledge an access to an array location if HVS = 1. While HVS = 1, SES cannot be changed. This bit is read only; writes have no effect. 0 = Program or erase pulse is not applied to the CMF array or shadow information 1 = Program or erase pulse is applied to the CMF array or shadow information
1	—	Reserved
2:4	SCLKR	System clock range. These bits are write protected by the SES bit. Writes to CMFCTL do not change SCLKR[0:2] if SES = 1. The default reset state of SCLKR[0:2] = 000 for a clock scaling of 1. 000 = Clock scaling of 1 (Not for Customer use.) 001 = Clock scaling of 1 010 = Clock scaling of 3/2 011 = Clock scaling of 2 100 = Clock scaling of 3 101 = Clock scaling of 4 110 = Reserved 111 = Reserved Refer to <a href="#">19.7.3 System Clock Scaling</a> for instructions on selecting a clock scaling factor.
5	—	Reserved
6:7	CLKPE	Clock period exponent. The CLKPE, CSC, and PE fields determine the value of the exponential clock multiplier, N. Refer to <a href="#">19.7.4 Exponential Clock Multiplier</a> for details. The CLKPE bits are write protected by the SES bit. Writes to CMFCTL will not change CLKPE if SES = 1. The default reset state of CLKPE is 00.
8	—	Reserved
9:15	CLKPM	Clock period multiple. This field determines the linear clock multiplier, M, according to the following equation: $M = 1 + \text{CLKPM}[0:6]$ The CLKPM bits are write protected by the SES bit. Writes to CMFCTL will not change CLKPM if SES = 1. The reset state of CLKPM = 0, for a multiplier of 1. Refer to <a href="#">19.7.5 Linear Clock Multiplier</a> for more information.
16:23	BLOCK [0:7]	Block program and erase select. The CMF EEPROM array blocks that are selected to be programmed or erased are the blocks for which BLOCK[M] = 1. Bit 16 controls block 0 and bit 23 controls block 7. On the 192-Kbyte array (Flash Module B), blocks 6 and 7 are not available, but these bits need to be set when doing a clear sensor operation. Warning: The block bit must be set only for the blocks currently being programmed. If the block bits are set for blocks that are not being programmed, the contents of the other blocks could be disturbed. The BLOCK[0:7] bits are write protected by the SES bit. Writes to CMFCTL will not change BLOCK[0:7] if SES = 1. BLOCK[0:7] default reset state is 0x00, not selected for program or erase. 0 = Array block M is not selected for program or erase 1 = Array block M is selected for program or erase
24	—	Reserved
25	CSC	Censor set or clear. CSC configures the CMF EEPROM for setting or clearing the CENSOR bits. If CSC=1 then CENSOR is configured for setting if PE = 0 or clearing if PE = 1. For more information on setting or clearing the CENSOR bits see section <a href="#">19.8.4 Setting and Clearing Censor</a> . The CSC bit is write protected by the SES bit. Writes to CMFCTL will not change CSC if SES = 1. 0 = Configure for normal operation (default value) 1 = Configure to set or clear the CENSOR bits

**Table 19-6 CMFCTL Bit Descriptions (Continued)**



Bit(s)	Name	Description
26	EPEE	EPEE pin status bit. The EPEE bit monitors the state of the external program/erase enable (EPEE) pin. EPEE has a digital filter that requires two consecutive samples to be equal before the output of the filter changes. The CMF samples EPEE when EHV is asserted and holds the EPEE state until EHV is negated. EPEE is a read-only bit; writes have no effect. 0 = High voltage operations are not possible 1 = High voltage operations are possible Refer to <a href="#">19.9.1 E<sub>P</sub>EE Signal</a> for more information.
27:28	—	Reserved
29	PE	Program or erase select. PE configures the CMF EEPROM for programming or erasing. When PE = 0, the array is configured for programming and if SES = 1 the SIE bit will be write locked. When PE = 1, the array is configured for erasing and SES will not write lock the SIE bit. The PE bit is write protected by the SES bit. Writes to CMFCTL will not change PE if SES = 1. 0 = Configure for program operation (default value) 1 = Configure for erase operation
30	SES	Start-end program or erase sequence. The SES bit is write protected by the HVS and EHV bits, unless the PAW bits are set to 0b1xx. Writes to CMFCTL will not change SES if HVS = 1 or EHV = 1. Refer to <a href="#">19.7.7 Starting and Ending a Program or Erase Sequence</a> for more information. 0 = CMF EEPROM not configured for program or erase operation 1 = Configure CMF EEPROM for program or erase operation
31	EHV	Enable high voltage. EHV can be asserted only after the SES bit has been asserted and a valid programming write(s) or erase hardware interlock write has occurred. If an attempt is made to assert EHV when SES is negated, or if a valid programming write(s) or erase hardware interlock write has not occurred since SES was asserted, EHV will remain negated. 0 = Program or erase pulse disabled 1 = Program or erase pulse enabled

### 19.2.2 CMF EEPROM Array Addressing

The CMF EEPROM array is addressed when an internal access has been initialized and ADDR[10:13] matches the array hardware mapping address. The CMF array location selected is determined by ADDR[14:29] and the bytes are selected by ADDR[30:31] and internal SIZE[0:1] information. [Table 19-6](#) and [Table 19-7](#) show the internal mapping of the flash array.

Information in the array is accessed in 32-byte pages. For each CMF module, two read page buffers are assigned to the low order addresses (ADDR[27:31]). The first page buffer is assigned to blocks zero to three; the second to blocks four to seven (for CMF Module A) or four to five (for CMF Module B).

Access time for data in the read page buffers is one system clock; access time for an off-page read is two system clocks. To prevent the BIU from accessing an unnecessary page from the array, the CMF EEPROM monitors the U-bus address to determine whether the required information is within one of the two read page buffers and the access is valid for the module. This strategy allows the CMF EEPROM to have a two-clock read for an off-page access and one clock for an on-page access.

The BIU does not recognize write accesses to the CMF array.

**Table 19-7 EEPROM Array Addressing**

0	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20	21	22	23	24	25	26	27	28	29	30	31
0000000								USIU Internal Mapping		Array Hardware Mapping		Block Address		Row Address					Column Address					Byte Addr							

**Table 19-8 CMF EEPROM Array Address Fields**

Bit(s)	Field	Description
0:6	—	The seven high-order address bits of a CMF EEPROM array access (or any MPC555 / MPC556 internal access) must equal zero.
7:9	USIU Internal Mapping	These bits (programmed in the USIU internal memory map register) specify one of eight locations for the MPC555 / MPC556 internal memory map.
10:13	Array Hardware Mapping	These bits determine the location of each array within the MPC555 / MPC556 internal memory map. Values are as follows: Flash module A = 0000 Flash Module B = 0001
14:16	Block Address	These three bits specify one of eight 32-Kbyte blocks within CMF Module A (000 to 111), or one of six 32-Kbyte blocks within CMF Module B (000 to 101)
17:23	Row Address	These seven bits select one of 128 rows within the 32-Kbyte block.
24:29	Column Address	These six bits select one of 64 (word-length) columns within the row. Note also the following: ADDR[24:26] select a 32-byte read page. ADDR[27:29] represent the read page word address. ADDR[24:25] select a 64-byte program page. ADDR[26:29] represent the program page word address.
30:31	Byte Address	Bits 30:31 select a byte within the column.

### 19.2.2.1 Read Page Buffers

Each CMF array has two 32-byte read page buffers. The fully independent buffers are located in two separate read sections of the array. Each page buffer status and address are monitored in the BIU. The status of the read page buffers is made invalid by any of the following operations:

- Reset
- Programming write
- Erase interlock write
- Setting EHV
- Clearing SES
- Setting or clearing SIE

Each access to the CMF EEPROM array determines whether the requested location is within the current pages. If the requested location is not within the read page buffers, the correct read page buffer is made invalid, and a new page of information is fetched from the array. The page buffer address is updated and status is made valid. If the requested location is within one of the current page buffers or has been fetched from the array, the selected bytes are transferred to the U-bus, completing the access. CMF EEPROM array accesses that make the page buffer(s) invalid (off-page reads) require two system clocks. CMF EEPROM array accesses that do not make the page buffer(s)

invalid (on-page reads) require one system clock. Read buffer management is transparent to user software and is taken care of in hardware.



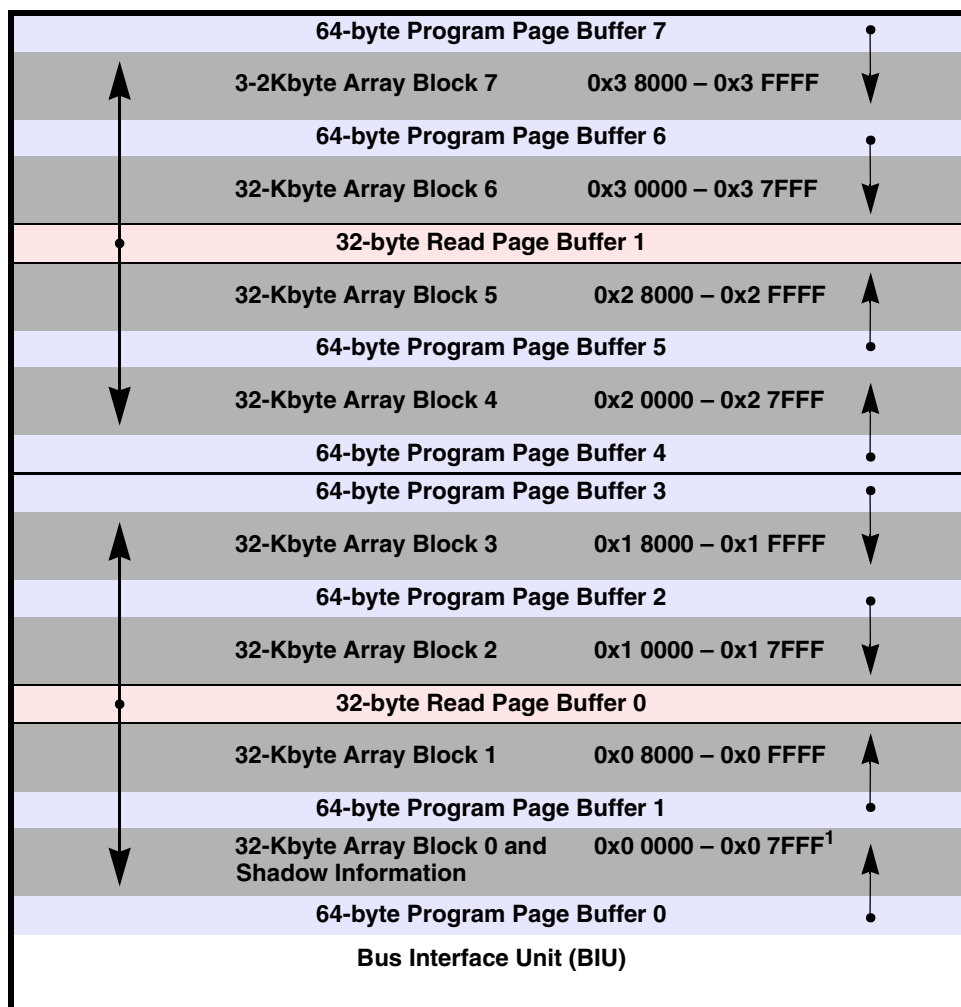
#### **19.2.2.2 Program Page Buffers**

The CMF EEPROM modules A and B can program up to eight and six 64-byte pages at one time, respectively. Each program page buffer is located in one program section. All program page buffers within a CMF module share the same block offset address. The block offset address is extracted from the address of the first programming write. To select the CMF EEPROM array block that will be programmed, the program page buffers use the CMF EEPROM array configuration and BLOCK[0:7].

The array block that will be programmed is selected by the BLOCK bit that is set. If BLOCK[M] = 1 then program buffer[M] is active and array block[M] is selected for programming.

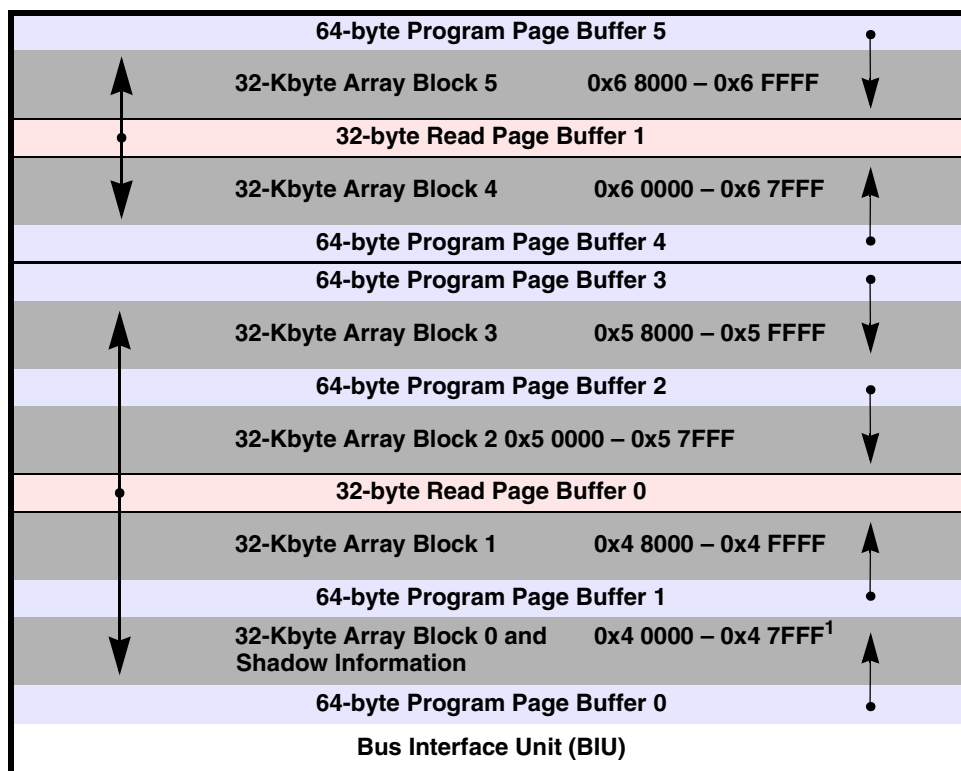
Bits in the program page buffers select the non-program state if SES = 0. During a program margin read, the program buffers update bits to the non-program state for bits that correspond to array bits that the program margin read has determined are programmed.

### 19.2.2.3 Array Configuration for CMF Module A



1: If SIE=1, then the shadow row is enabled instead of the flash block. Shadow locations 0x00 to 0x03 are reserved for the Internal Flash Reset Configuration word. Shadow locations 0x04 to 0x0F are Reserved by Motorola for possible future use.

### 19.2.2.4 Array Configuration for CMF Module B



1. If SIE=1, then the shadow row is enabled instead of the flash block. Locations 0x4 00000 to 0x4 000F of the shadow row are Reserved by Motorola for possible future use.

## 19.3 Shadow Information

Programming the shadow information uses the same procedure as programming the array, except that there are only 256 bytes available in the shadow row. Before starting the program sequence SIE must equal one.

The SIE bit is write protected by the SES bit for programming operation. Writes will have no effect if (SES = 1 and PE = 0). The SIE bit can be read whenever the registers are enabled.

When SIE = 1, normal array accesses are disabled and the shadow information is enabled. When an array location is read using supervisor data in this mode, the shadow information is read from a location determined by the column, 32-byte read page select and read page word addresses (ADDR[24:29]) of the access. Accessing the CMF control block registers accesses the registers and not the shadow information. The read page buffer address monitor is reset whenever SIE is modified, making the next CMF array access an off-page access.

The default reset state of SIE is normal array access (SIE = 0).



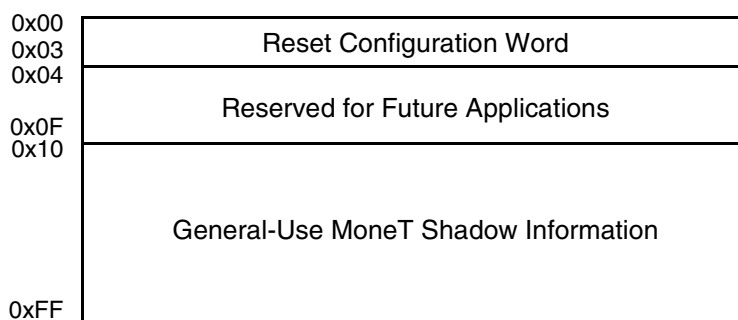
## NOTE

When SIE = 1, only program page buffer zero can be programmed. All programming writes to the CMF will be directed to program page buffer 0 if SIE = 1. In addition, the other program page buffers cannot be accessed and will not apply any programming voltages to their CMF array blocks while programming the shadow information.



### 19.3.1 Address Range of Shadow Information

The address range of the shadow information is the entire address range of the CMF EEPROM array but the high order array addresses, ADDR[14:23], are not used to encode the location. The first 16 bytes (ADDR[24:29] = 0x00 to 0x0F) of the 256 bytes of shadow locations are withheld by Motorola for the reset configuration word and future applications. The remaining 240 bytes are available as supervisor data. This is shown in [Figure 19-2](#).



**Figure 19-2 Shadow Information**

### 19.3.2 Reset Configuration Word (CMFCFIG)

The CMF EEPROM reset configuration word is implemented in the first word (ADDR[24:29] = 0x00) of the special shadow locations. The reset configuration word along with the rest of the shadow information words is located in supervisor data address space. The purpose of the reset configuration word is to provide the system with an alternative internal source for the reset configuration.

Note that with the exception of bit 20, the bits in the CMFCFIG are identical to those in the USIU hard reset configuration word. Refer to [7.5.2 Hard Reset Configuration Word](#) for descriptions of these bits.

## CMFCFIG — Hard Reset Configuration Word



MSB																
0	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	
EARB	IP	BDRV	BDIS	BPS		RESERVED			DBGC		DBPC	ATWC	EBDF		Re-served	
LSB																
16	17	18	19	20	21	22	23	24	25	26	27	28	29	30	31	
PRPM	SC		ETRE	FLEN	EN_COMP	EXC_COMP	Reserved					ISB			DME	

During reset the  $\overline{HC}$  bit (“has configuration,” bit 20) and the USIU configure the CMF EEPROM module to provide CMFCFIG. If  $\overline{HC} = 0$  and the USIU requests internal configuration during reset the reset configuration word will be provided by CMFCFIG.

The default reset state of the CMFCFIG after an erase operation of the CMF module A block 0 is no configuration word available ( $\overline{HC} = 1$ ).

### 19.4 Array Read Operation

The CMF EEPROM array is available for read operation under most conditions while the device is powered up. Reads of the array are not allowed under any of the following conditions:

- During master or soft reset
- ACCESS = 0 and CENSOR[0:1] = 11 or 00
- While the CMF EEPROM is disabled

During programming and erase operations, while the high voltage is applied to the array, the BIU does not acknowledge a CMF array read. At certain points, as defined in the program or erase sequence, reading the array results in a margin read. These margin reads return the status of the program or erase operation and not the data in the array.

The type of CMF EEPROM array read is determined by comparing the address of the requested information with the address of the read page buffers. If the requested address is not within one of the read page buffers or if the read page buffer has been made invalid, an off-page read results. This read updates the read page buffer address of the selected array block, copies the information from the array into the read page buffer, and drives a word onto the data bus. The off-page read requires a minimum of two clocks, while margin off-page reads require additional clocks.

If the address of the requested information is within the address ranges of either of the read page buffers, an on-page read is performed. This requires one clock to transfer information from the read page buffer onto the data bus. See section [19.2.2 CMF EEPROM Array Addressing](#) for more information on array accesses.

## 19.5 Programming the CMF Array



To modify the charge stored in the isolated element of the CMF bit from a logic one state to a logic zero state, a programming operation is required. This programming operation applies the required voltages to change the charge state of the selected bits without changing the logic state of any other bits in the CMF array. The program operation cannot change the logic zero state to a logic one state; this must be done by the erase operation. Programming uses a set of program buffers of 64 bytes each to store the required data, an address offset buffer to store the starting address of the block(s) to be programmed and a block select buffer that stores information on which block(s) are to be programmed. Any number of the array blocks may be programmed at one time.

### WARNING

Do not program any page more than once after a successful erase operation. While this will not physically damage the array it will cause an increased partial disturb time for the unselected bits on the row and columns that are not programmed. If this happens, a full erase of all blocks being programmed must be done before the CMF EEPROM can be used reliably.

If block M of the CMF EEPROM is protected ( $\text{PROTECT}[M] = 1$ ), it will not be programmed. Also, if  $\text{EPEE} = 0$ , no programming voltages will be applied to the array. Software should verify the state of EPEE prior to programming (programming will fail if  $\text{EPEE} = 0$ ). The user should also insure that the programming voltage ( $5.0 \pm 0.25$  volts) is applied to VPP.

### 19.5.1 Program Sequence

The CMF EEPROM module requires a sequence of writes to the high voltage control register (CMFCTL) and to the programming page buffer(s) in order to enable the high voltage to the array or shadow information for program operation. See [Table 19-4](#) for the programming algorithm bit settings.

The required program sequence follows.

1. Write  $\text{PROTECT}[0:7]$  to disable protection on blocks to be programmed.
2. Write PAWS to 0b100, write  $\text{NVR} = 1$ , write  $\text{GDB} = 1$ .
3. Using [19.7.6 A Technique to Determine SCLKR, CLKPE, and CLKPM](#), program the following fields:
  - Pulse width timing control fields for a program pulse
  - $\text{BLOCK}[0:7]$  to select the array blocks to be programmed
  - $\text{PE} = 0$  in the CMFCTL register
4. Write  $\text{SES} = 1$  in the CMFCTL register.

### NOTE

Step 4 can be accomplished with the same write as that in step 3. It is listed as a separate step in the sequence for looping.

5. Write to the 64-byte array locations to be programmed. This updates the programming page buffer(s) with the information to be programmed. The last write to a word within the program page buffer will be saved for programming. All accesses of the array after the first write are to the same block offset address (ADDR[17:25]) regardless of the address provided. Thus the locations accessed after the first programming write are limited to the page locations to be programmed. Off-page read accesses of the CMF array after the first programming write are program margin reads. (See section [19.5.2 Program Margin Reads](#).)



To select the CMF EEPROM array block(s) to be programmed, the program page buffers use the CMF EEPROM array configuration and BLOCK[0:7]. Subsequent writes fill in the programming page buffers using the block address to select the program page buffer and the page word address (ADDR[26:29]) to select the word in the page buffer.

6. Write EHV = 1 in the CMFCTL register.

#### NOTE

If a program buffer word has not received a programming write no programming voltages will be applied to the drain of the corresponding word in the array. Also, at this point writes to the program page buffers are disabled until SES has been cleared and set.

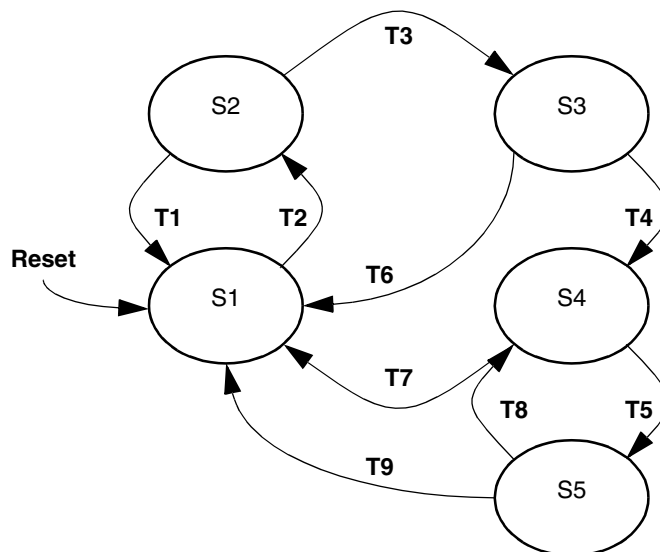
7. Read the CMFCTL register until HVS = 0.
8. Write EHV = 0.
9. To verify the programming, read the words of the pages that are being programmed. These are program margin reads. (See [19.5.2 Program Margin Reads](#).) If any bit is a 1 after reading all of the locations that are being programmed, then another pulse needs to be applied to the these locations. If all the locations verify as programmed go to step 11.

#### WARNING

After a program pulse, read at least one location with ADDR[26] = 0 and one location with ADDR[26] = 1 on each programmed page. Failure to do so may result in the loss of information in the CMF EEPROM array. While this will not physically damage the array a full erase of all blocks being programmed must be done before the CMF EEPROM can be used reliably. For more information see [19.5.3 Over-Programming](#).

To reduce the time for verification, read two locations in each program page that is being programmed after reading a non-programmed bit. The first location must be a location with ADDR[26] = 0, while the second must use ADDR[26] = 1. In addition, after a location has been fully verified (all bits are programmed) it is not necessary to verify the location again, since no further programming voltages will be applied to the drain of the corresponding bits. This will reduce the time required to program the array.

10. If the margin read is successful, then write SES = 0 in the CMFCTL register, otherwise do the following:
- Write new pulse width parameters (if required per [Table 19-4](#)) - SCLKR, CLKPE, CLKPM.
  - Write new values for PAWS, NVR, and GDB (if required per [Table 19-4](#)).
  - Go back to step 6 to apply additional programming pulses.
11. If more information needs to be programmed, go back to step 2.



**Figure 19-3 Program State Diagram**

**Table 19-9 Program Interlock State Descriptions**



State	Mode	Next State	Transition Requirement	
S1	Normal Operation: Normal array reads and register accesses. The block protect information and pulse width timing control can be modified.	S2	T2	Write PE = 0, SES = 1
S2	First Program Hardware Interlock Write: Normal read operation still occurs. The array will accept programming writes. Accesses to the registers are normal register accesses. A write to CMFCTL can not change EHV at this time. If the write is to a register, no data is stored in the program page buffers, and the CMF remains in state S2.	S1	T1	Write SES = 0 or a master reset
		S3	T3	Hardware Interlock A successful write to any CMF array location. This programming write latches the selected word of data into the programming page buffer and the address is latched to select the location to be programmed. Once a bit has been written then it will remain in the program buffer until another write to the word or a write of SES = 0 or a program margin read determines that the state of the bit needs no further modification by the program operation. If the write is to a register no data will be stored in the program page buffers and the CMF will remain in state S2.
S3	Expanded Program Hardware Interlock Operation: Program margin reads will occur. Programming writes are accepted so that all program pages may be programmed. These writes may be to any CMF array location. The program page buffers will be updated using only the data, the lower address (ADDR[26:29]) and the block address. Accesses to the registers are normal register accesses. A write to CMFCTL can change EHV. If the write is to a register, no data is stored in the program page buffer.	S1	T6	Write SES = 0 or a master reset
		S4	T4	Write EHV = 1
S4	Program Operation: High voltage is applied to the array or shadow information to program the CMF bit cells. The pulse width timer is active if SCLKR[0:2] ≠ 0 and HVS can be polled to time the program pulse. No further programming writes are accepted. During programming the array does not respond to any access. Accesses to the registers are allowed. A write to CMFCTL can change EHV only.	S1	T7	Master reset
		S5	T5	Write EHV = 0, disable the internal memory map or a soft reset.

**Table 19-9 Program Interlock State Descriptions (Continued)**

State	Mode	Next State	Transition Requirement	
S5	Program Margin Read Operation: These reads determines if the state of the bits on the selected page needs further modification by the program operation. Once a bit is fully programmed, the data stored in the program page is updated. No further programming occurs for that bit, and the value read is a 0. While it is not necessary to read all words on a page to determine if another program pulse needs to be applied, all pages being programmed must be read once after each program pulse.	S4	T8	Write EHV = 1
		S1	T9	Write SES = 0 or a master reset.

### 19.5.2 Program Margin Reads

The CMF EEPROM provides a program margin read with electrical margin for the program state. Program margin reads provide sufficient margin to assure specified data retention. The program margin read is enabled when SES = 1 and a programming write has occurred. To increase the access time of the program margin read, the off-page access time is four clocks instead of the usual two-clock off-page read access time. The program margin read and subsequent on-page program verify reads return a one for any bit that has not been completely programmed. Bits that the programming write left in the non-programmed state return zero when read. Bits that have completed programming return zero when read and update the data in the programming page buffer so that no further programming of those bits will occur. The program margin read occurs during the off-page read. A program margin read must be performed for all pages that are being programmed after each program pulse.

**Table 19-10 Results of Programming Margin Read**

Current Data in the Program Page Buffer <sup>1</sup>	Current State of Bit	Data Read During Margin Read <sup>2</sup>	New Data for the Program Page Buffer <sup>1</sup>
0	Programmed (0)	0	1
0	Erased (1)	1	0
1	Programmed (0)	0	1
1	Erased (1)	0	1

**NOTES:**

1. 0 = bit needs further programming  
1 = bit does not need further programming
2. A "0" read during the margin read means that the bit does NOT need further programming. A "1" means the bit needs to be programmed further.



## CAUTION

Failure to read each page that is being programmed after each program pulse may result in the loss of information in the CMF EEPROM array. While this will not physically damage the array a full erase of all blocks being programmed must be performed before the CMF EEPROM can be used reliably. For more information, see [19.5.3 Over-Programming](#).



### 19.5.3 Over-Programming

Either of the following events results in an over-programmed state:

- Programming a CMF bit without a program margin read after each program pulse
- Exceeding the specified program times or voltages

Once a CMF bit has been over-programmed, data in the array block (32 Kbytes) that is located in the same column is lost, since the over-programmed bit causes the entire column to appear programmed. To restore an array block with an over-programmed bit, the block must be erased.

### 19.6 Erasing CMF Array Blocks

To modify the charge stored in the isolated element of the CMF bit from a logic zero state to a logic one state, an erase operation is required. The erase operation cannot change the logic one state to a logic zero state; this is accomplished by the program operation. In the CMF EEPROM, erase is a bulk operation that affects the stored charge of all the isolated elements in an array block.

To make the CMF module block-erasable, the array is divided into blocks that are physically isolated from each other. Each of the array blocks may be erased in isolation or in any combination. The CMF array block size is fixed for all blocks in the module at 32 Kbytes. CMF module A consists of eight array blocks; CMF module B consists of six blocks. Array blocks of the CMF EEPROM that are protected (PROTECT[M] = 1) are not erased. In addition, if EPEE = 0 no erase voltages are applied to the array.

The array blocks selected for erase operation are determined by BLOCK[0:7] and the array configuration.

#### 19.6.1 Erase Sequence

The CMF EEPROM module requires a sequence of writes to the high voltage control register (CMFCTL) and an erase interlock write in order to enable the high voltage to the array and shadow information for erase operation. See [Table 19-5](#) for erase algorithm bit settings. The erase sequence follows.

1. Write PROTECT[0:7] to disable protect for the blocks to be erased.
2. Write PAWS to 0b100, NVR to 1, and GDB to 1.
3. Using [19.7.6 A Technique to Determine SCLKR, CLKPE, and CLKPM](#), write the pulse width timing control fields for an erase pulse, BLOCK[0:7] to select the blocks to be erased, PE = 1 and SES = 1 in the CMFCTL register. Set the initial



pulse width bit settings per [Table 19-5](#).

4. Execute an erase interlock write to any CMF array location.
5. Write EHV = 1 in the CMFCTL register.
6. Read the CMFCTL register until HVS = 0.
7. Write EHV = 0 in the CMFCTL register.
8. To verify the erase operation, read all locations that are being erased, including the shadow information if the block containing it is erased. Off-page reads are erase margin reads that update the read page buffer. (See section [19.6.2 Erase Margin Reads](#).) If all the locations read as erased, go to step 9.

#### NOTE

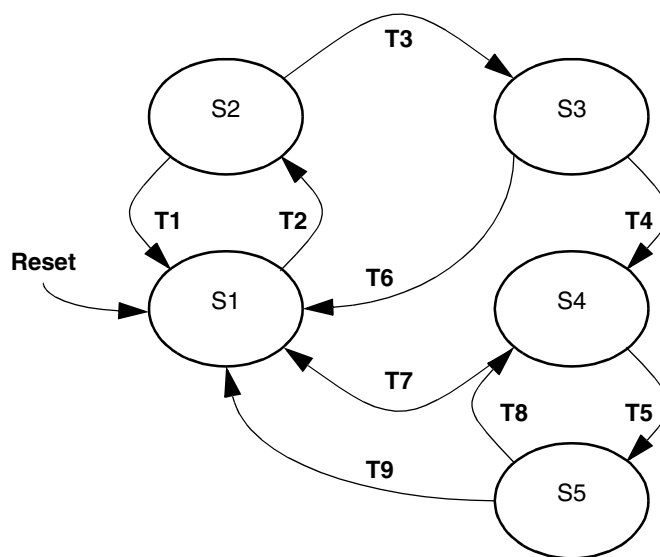
Do not perform erase margin reads until reaching the condition PAWS=0b111, NVR=0 and GDB=1.

9. To reduce the time used for erase margin reads, upon the first read of a zero, do the following:
  - a. Write new pulse width parameters, SCLKR, CLKPE, and CLKPM (if required per [Table 19-5](#)).
  - b. Write new PAWS value (if required per [Table 19-5](#)).
  - c. Write new values for NVR and GDB (if required per [Table 19-5](#)).
  - d. Go back to step 5 to apply additional erase pulses.

#### NOTE

After a location has been verified (all bits erased), it is not necessary to verify the location after subsequent erase pulses.

10. Write SES = 0 in the CMFCTL register.



**Figure 19-4 Erase State Diagram**



**Table 19-11 Erase Interlock State Descriptions**

State	Mode	Next State	Transition Requirement	
S1	Normal Operation: Normal array reads and register accesses. The Block protect information and pulse width timing control can be modified.	S2	T2	Write PE = 1, SES = 1.
S2	Erase Hardware Interlock Write: Normal read operation still occurs. The CMF accepts the erase hardware interlock write. This write may be to any CMF array location. Accesses to the registers are normal register accesses. A write to CMFCTL can not set EHV at this time. A write to the register is not an erase hardware interlock write, and the CMF remains in state S2.	S1	T1	Write SES = 0 or a master reset
		S3	T3	Hardware Interlock A successful write to any CMF array location is the erase interlock write. If the write is to a register the erase hardware interlock write has not been done and the CMF will remain in state S2.
S3	High Voltage Write Enable Erase margin reads will occur. Accesses to the registers are normal register accesses. A write to CMFCTL can change EHV.	S1	T6	Write SES = 0 or a master reset
		S4	T4	Write EHV=1
S4	Erase Operation: High voltage is applied to the array blocks to erase the CMF bit cells. The pulse width timer is active if SCLKR[0:2] ≠ 0, and HVS can be polled to time the erase pulse. During the erase operation, the array does not respond to any address. Accesses to the registers are allowed. A write to CMFCTL can change EHV only.	S1	T7	Master reset
		S5	T5	Write EHV = 0, disable the internal memory map or a soft reset
S5	Erase Margin Read Operation: These reads determine whether the state of the bits in the selected blocks needs further modification by the erase operation. Once a bit is fully erased it returns one when read. All words within the blocks being erased must be read to determine whether the erase operation is completed.	S4	T8	Write EHV = 1
		S1	T9	Write SES = 0 or a master reset

### 19.6.2 Erase Margin Reads

The CMF EEPROM provides an erase margin read with electrical margin for the erase state. Erase margin reads provide sufficient margin to ensure specified data retention. The erase margin read is enabled when SES = 1 and the erase write has occurred. The erase margin read and subsequent on-page erase verify reads return a zero for any bit that has not been completely erased. Bits that have completed erasing return one when read. To increase the access time of the erase margin read, the off-page access time is 16 clocks instead of the usual two clock off-page read access time. The erase margin read occurs during an off-page read. All locations within the block(s) being erased must return one when read to determine that no more erase pulses are required.

### 19.6.3 Erasing Shadow Information Words

The shadow information words are erased with CMF array block zero. To verify that the shadow information words are erased, the SIE bit in CMFMCR must be set to one

during the erase margin read while the shadow information is read. For the erase operation to be completed, block zero must also be fully verified.



#### NOTE

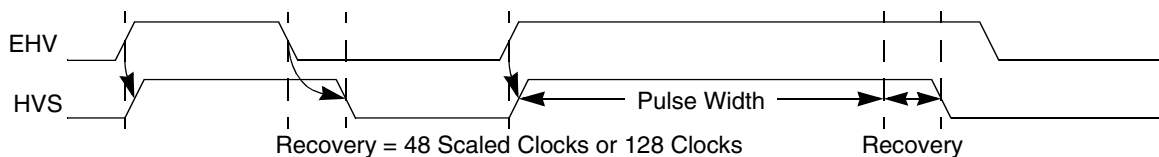
Setting the SIE bit disables normal array access. SIE should be cleared after verifying the shadow information.

### 19.7 Voltage Control for Programming and Erasing

Bits for controlling the voltage during programming and erasing are found in the CMFCTL register.

#### 19.7.1 Pulse Status

During a program or erase pulse, the HVS bit is set while the pulse is active or during recovery. The BIU does not acknowledge an access to an array location if HVS = 1. While HVS = 1, SES cannot be changed. The program or erase pulse becomes active by setting the EHV bit and is terminated by clearing EHV or by the pulse width timing control.



**Figure 19-5 Pulse Status Timing**

The recovery time is the time required for the CMF EEPROM to remove the program or erase voltage from the array or shadow information before switching to another mode of operation. The recovery time is determined by the system clock range (SCLKR[0:2]) and the PE bit. If SCLKR = 000, the recovery time is 128 clocks. Otherwise, the recovery time is 48 periods of the scaled clock.

Once reset is completed HVS will indicate no program or erase pulse (HVS = 0).

#### 19.7.2 Pulse Width Timing Equation

To control the pulse widths for program and erase operations, the CMF EEPROM uses the system clock and the timing control in CMFCTL. The total pulse time is defined by the following pulse width equation:

$$\text{Pulse Width} = \text{System Clock Period} \cdot R \cdot 2^N \cdot M$$



Where:  $R = \text{Clock Scaling}$   
 $N = 5 + \text{CLKPE}[0:1] + ((\text{PE} \mid \text{CSC}) \cdot 10)$   
 $M = 1 + \text{CLKPM}[0:6]$

The following subsections explain how the values for R, N, and M are determined.

### 19.7.3 System Clock Scaling

The first term of the pulse width timing equation is the clock scaling, R. The value of R is determined by the system clock range (SCLKR) field. SCLKR defines the pulse timer's base clock using the system clock. Use [Table 19-12](#) to set SCLKR based upon the system clock frequency. The system clock period is multiplied by the clock scaling value to generate a 83.3-ns to 125-ns scaled clock. This scaled clock is used to run the charge pump submodule and the next functional block of the timing control.

**Table 19-12 System Clock Range**

SCLKR[0:2]	System Clock Frequency (MHz)		Clock Scaling (R)
	Minimum	Maximum	
000	<b>Not for customer use.</b> Program and erase timing control not specified and pulse is not terminated by the timer control. Recovery time is specified to be 128 clocks.		1
001	8	12	1
010	12	18	3/2
011	18	24	2
100	24	36	3
101	36	40	4
110 and 111	Reserved by Motorola for future use		

#### NOTE

The minimum specified system clock frequency for performing program and erase operations is 8.0 MHz. The CMF EEPROM does not have any means to monitor the system clock frequency and will not prevent program or erase operation at frequencies below 8.0 MHz. Attempting to program or erase the CMF EEPROM at system clock frequencies lower than 8.0 MHz will not damage the device if the maximum pulse times and total times are not exceeded. While some bits in the CMF EEPROM array may change state if programmed or erased at system clock frequencies below 8.0 MHz, the full program or erase transition is not ensured.

#### WARNING

Never stop the U-bus clock or alter its frequency during a program or erase operation. Changing the clock frequency during a program or erase operation results in inaccurate pulse widths and variations in the charge pump output. This includes loss of system clock/PLL.

## 19.7.4 Exponential Clock Multiplier

The second term in the pulse width timing equation is the exponential clock multiplier, N. The program pulse number (pulse), clock period exponent (CLKPE), CSC, and PE define the exponent in the  $2^N$  multiply of the clock period. The exponent, N, is defined by the equation:

$$N = 5 + \text{CLKPE}[0:1] + ((\text{PE} \mid \text{CSC}) \cdot 10)$$

All of the exponents are shown in [Table 19-12](#).

**Table 19-13 Clock Period Exponent and Pulse Width Range**

PE   CSC	CLKPE[0:1]	Exponent (N)	Pulse Width Range for all System Clock Frequencies from 8.0 MHz to 40.0 MHz.					
			Minimum Pulse Width			Maximum Pulse Width		
			8 MHz <sup>1</sup> $2^N \cdot 1.25\text{E-}7$	10 MHz <sup>1</sup> $2^N \cdot 1\text{E-}7$	12 MHz <sup>1</sup> $2^N \cdot 0.833\text{E-}7$	8 MHz <sup>1</sup> $2^N \cdot 1.25\text{E-}07$	10 MHz <sup>1</sup> $2^N \cdot 1\text{E-}7$	12 MHz <sup>1</sup> $2^N \cdot 0.833\text{E-}7$
0	00	5	4 $\mu\text{s}$	3.2 $\mu\text{s}$	2.7 $\mu\text{s}$	512 $\mu\text{s}$	409.6 $\mu\text{s}$	341.3 $\mu\text{s}$
	01	6	8 $\mu\text{s}$	6.4 $\mu\text{s}$	5.3 $\mu\text{s}$	1.024 ms	819.2 $\mu\text{s}$	682.7 $\mu\text{s}$
	10	7	16 $\mu\text{s}$	12.8 $\mu\text{s}$	10.7 $\mu\text{s}$	2.048 ms	1.6384 ms	1.365 ms
	11	8	32 $\mu\text{s}$	25.6 $\mu\text{s}$	21.3 $\mu\text{s}$	4.096 ms	3.2768 ms	2.731 ms
1	00	15	4.096 ms	3.28 ms	2.73 ms	524.29 ms	419.43 ms	349.5 ms
	01	16	8.192 ms	6.55 ms	5.46 ms	1.05 s	838.86 ms	699.1 ms
	10	17	16.384 ms	13.11 ms	10.92 ms	2.10 s	1.68 s	1.398 s
	11	18	32.768 ms	26.21 ms	21.85 ms	4.19 s	3.35 s	2.796 s

NOTES:

1. CMF clock frequency after SCKLR scaling. Example: A 40 MHz system clock scaled by 4 (SCKLR[0:2] = 0b101) results in an equivalent CMF clock of 10 MHz.

## 19.7.5 Linear Clock Multiplier

The third term of the pulse width timing equation is the linear clock multiplier, M. The clock period multiplier, CLKPM[0:6], defines a linear multiplier for the program or erase pulse. The multiplier, M, is defined by the equation:

$$M = 1 + \text{CLKPM}[0:6]$$

This allows for the program/erase pulse to be from one to 128 times the pulse set by the system clock period, SCKLR[0:2] and CLKPE[0:1].

The default reset state of CLKPM[0:6] = 000 0000 for a multiplier of one.

## 19.7.6 A Technique to Determine SCKLR, CLKPE, and CLKPM

The following example determines the values of the SCKLR, CLKPE, and CLKPM fields for a 25.6  $\mu\text{s}$  program pulse, PE = 0, in a system with a 40 MHz system clock.



In this example system clock frequency = 40 MHz; the system clock period is therefore 25 ns.



1. Determine SCLKR:  
From [Table 19-12](#) a 40 MHz system clock uses SCLKR[0:2] = 0b101, R = 4.
2. Determine CLKPE:  
From [Table 19-13](#) a 25.6  $\mu$ s program pulse, PE = 0, can be generated by exponents in the range of N = 5, 6, 7, or 8. While any of these values can be selected CLKPE[0:1] = 0b00, N = 5, will be used for the example.
3. Determine CLKPM:  
Using the selected values of N and R in the pulse width equation and solving for M yields M = 8. Therefore, CLKPM[0:6] = 0x7 (0b0000111).
4. Check the results:  
Pulse Width = System Clock Period  $\cdot$  R  $\cdot$  2<sup>N</sup>  $\cdot$  M  
Using SCLKR[0:2] = 0b101, CLKPE[0:1] = 0b00, CLKPM[0:6] = 0b0000111 and PE = 0 at 40 MHz system clock. Pulse Width = 25 ns  $\cdot$  4  $\cdot$  2<sup>5</sup>  $\cdot$  8 = 25.6  $\mu$ s program pulse.

### 19.7.7 Starting and Ending a Program or Erase Sequence

The SES bit is used to signal the start and end of a program or erase sequence. At the start of a program or erase sequence, SES is set (written to a one). This locks PROTECT[0:7], SCLKR[0:2], CLKPE[0:1], CLKPM[0:6], BLOCK[0:7], CSC and PE. If PE = 0 and SES = 1, SIE is write-locked. At this point the CMF EEPROM is ready to receive either the programming writes or the erase interlock write.

#### NOTE

The erase interlock write is a write to any CMF EEPROM array location after SES is set and PE = 1.

If the PE bit is a zero, the CMF BIU accepts programming writes to the CMF array address for programming. The first programming write selects the program page offset address (ADDR[17:25]) to be programmed along with the data for the programming buffers at the location written. All programming writes after the first will update the program buffers using the lower address (ADDR[26:29]) and the block address (ADDR[14:16]) to select the program page buffers to receive the data. For further information see section [19.2.2.2 Program Page Buffers](#). After the data has been written to the program buffers the EHV bit is set (written to a one) to start the programming pulse and lock out further programming writes.

If the PE bit = 1, the CMF BIU accepts writes to any CMF array address as an erase-interlock write. An erase interlock write is required before the EHV bit can be set.

At the end of the program or erase operation the SES bit must be cleared (written to a zero) to return to normal operation and release the program buffers, PROTECT[0:7], SCLKR[0:2], CLKPE[0:1], CLKPM[0:6], BLOCK[0:7], CSC and PE.

The default reset state of SES is not configured for program or erase operation (SES = 0).

### 19.7.8 Controlling the Program/Erase Voltage

The external program or erase enable pin (EPEE) and EHV are used to control the application of the program or erase voltage to the CMF EEPROM module. High voltage operations to the CMF EEPROM array, special MoneT shadow locations or FLASH NVM registers can occur only if EHV = 1 and EPEE = 1.

Only after the correct hardware and software interlocks have been applied to the CMF EEPROM can EHV be set. Once EHV is set SES cannot be changed and attempts to read the array will not be acknowledged.

The default reset state of EHV disables program or erase pulses (EHV = 0). A master reset while EHV = 1 terminates the high voltage operation, and CMF generates the required sequence to disable the high voltage without damage to the high voltage circuits. A soft reset or disabling the internal memory map clears EHV, terminating the high voltage pulse.

## 19.8 Censored and Non-Censored Accesses

The MPC555 / MPC556 always operates in one of two modes: censored or uncensored.

### 19.8.1 Uncensored Mode

Uncensored mode provides no censorship. In uncensored mode the FIC, ACCESS, and CENSOR[0:1] bits are irrelevant. The MPC555 / MPC556 operates in uncensored mode unless a specific event occurs to place the device in censored mode.

### 19.8.2 Censored Mode

The MPC555 / MPC556 enters censored mode in response to any of the following events:

- Booting from external memory
- Any CMF array access from an external master
- Entering background debug mode.

The CMF EEPROM censorship mechanism provides several censorship levels. Four bits in CMFMCR are used to configure the CMF censorship level. These bits are listed in [Table 19-14](#).

**Table 19-14 Censorship Control Bits**

ACCESS	Enables a CMF EEPROM to bypass the censorship
FIC	Overrides CENSOR[0:1] to force information censorship if ACCESS = 0
CENSOR[0:1]	Determine the censorship level of the CMF

In censored mode, the ACCESS and CENSOR bits work together according to [Table 19-15](#).



**Table 19-15 Levels of Censorship**

ACCESS	CENSOR[0:1]	Description
0	11	Information censorship, No CMF array accesses allowed
0	01 or 10	No censorship, CMF array accesses allowed
0	00	Cleared censorship, No CMF array accesses allowed
1	XX	No censorship, CMF array accesses allowed

There are two states of censorship: information censorship (CENSOR[0:1] = 11) and cleared censorship (CENSOR[0:1] = 00). In the information censorship state the entire CMF array must be erased to clear CENSOR[0:1]. In the cleared censorship or no censorship states the bits in CENSOR[0:1] may be set without modifying the information in the CMF array. When FIC=1, the CENSOR bits have no effect upon censorship.

While the device is in uncensored mode, ACCESS may be set to allow the device to enter censored mode and still access the CMF array. ACCESS may not be set while the device is in censored mode but may be cleared.

The default reset state of ACCESS is zero, so that FIC and CENSOR[0:1] control the level of censorship to the CMF EEPROM array. All accesses to the CMF EEPROM array are allowed if ACCESS=1.

If an access is attempted when the device is in censored mode and the following condition holds, the CMF EEPROM module disallows access to the array and signals a bus error:

$$((\text{CENSOR}[0] = \text{CENSOR}[1]) | (\text{FIC} = 1)) \text{ AND } (\text{ACCESS} = 0)$$

If CENSOR[0:1] is in the no-censorship state, however (CENSOR[0]≠CENSOR[1]), the CMF EEPROM module recognizes accesses to its address space.

When FIC = 1, the CENSOR bits have no effect upon censorship. If ((FIC = 1) and (ACCESS = 0)) the CMF is in information censorship mode. If ((FIC = 1) and (ACCESS = 1)), the CMF is in normal access mode. This arrangement aids in the development of custom techniques for controlling the ACCESS bit without setting CENSOR[0:1] to the information censorship state. Using FIC to force information censorship allows testing of the hardware and software for setting ACCESS without setting CENSOR[0:1] = 11.

The default reset state of FIC is normal censorship operation (FIC = 0).

### 19.8.3 Device Modes and Censorship Status

**Table 19-16** summarizes the various combinations of censorship mode and states of the ACCESS, FIC, and CENSOR[0:1] bits.

When booting from the internal flash, the default state is #8 unless BDM was entered, or a slave access to the MPC555 / MPC556 occurred. When any of these three conditions occur, then the state of CENSOR[0:1] determine whether the flash array can be accessed:

1. BDM is active
2. Accessing the MPC555 / MPC556 flash via a slave mode read
3. Booting from an external memory



**Table 19-16 CMF EEPROM Devices Modes and Censorship Status**

Device Mode	Censored					Uncensored					
ACCESS	0					1		0		1	
FIC	0			1		0	1	0	1	0	1
CENSOR[0:1]	00	01 or 10	11	00, 01 or 10	11	00, 01, 10 or 11					
<b>CMF EEPROM Status</b>	<b>#1</b>	<b>#2</b>	<b>#3</b>	<b>#4</b>	<b>#5</b>	<b>#6</b>	<b>#7</b>	<b>#8</b>	<b>#9</b>	<b>#10</b>	<b>#11</b>
#1	CMF array can not be accessed. ACCESS can not be changed. FIC can be set. CENSOR[0:1] can be set. CENSOR[0:1] can not be cleared.										
#2	CMF array can be accessed. ACCESS can not be changed. FIC can be set. CENSOR[0:1] can be set. CENSOR[0:1] can be cleared.										
#3	CMF array can not be accessed. ACCESS can not be changed. FIC can be set. CENSOR[0:1] can not be cleared.										
#4	CMF array can not be accessed. ACCESS can not be changed. FIC can not be changed. CENSOR[0:1] can be set. CENSOR[0:1] can not be cleared.										
#5	CMF array can not be accessed. ACCESS can not be changed. FIC can not be changed. CENSOR[0:1] can not be cleared.										
#6	CMF array can be accessed. ACCESS can be cleared. FIC can be set. CENSOR[0:1] can be changed.										
#7	CMF array can be accessed. ACCESS can be cleared. FIC can not be changed. CENSOR[0:1] can be changed.										
#8	CMF array can be accessed. ACCESS can be changed. FIC can be set. CENSOR[0:1] can be changed.										
#9	CMF array can be accessed. ACCESS can be changed. FIC can not be changed. CENSOR[0:1] can be changed.										
#10	CMF array can be accessed. ACCESS can be changed. FIC can be set. CENSOR[0:1] can be changed.										
#11	CMF array can be accessed. ACCESS can be changed. FIC can not be changed. CENSOR[0:1] can be changed.										

 = Indicates that the CMF array can not be accessed.

The only way CENSOR[0:1] can be changed is by setting or clearing the FLASH NVM fuses. In the information censorship state, CENSOR[0:1] must be cleared to the cleared censorship state before CENSOR[0:1] can be put into the no-censorship state.

### CAUTION

Clearing the CENSOR[0:1] bits causes the entire CMF array to be erased.

## 19.8.4 Setting and Clearing Censor

The value of each bit in CENSOR[0:1] is determined by the state of two NVM bits in a special NVM fuse as shown in [Table 19-17](#). These two NVM bits are not part of the main flash array. The NVM fuse is not writable but instead may be set or cleared. The two NVM bits in the NVM fuse are programmed and erased simultaneously to change

the value of the NVM fuse. Reading CENSOR[0:1] while setting or clearing with the high voltage applied (CSC = 1 and EHV = 1) will return zeroes.



**Table 19-17 NVM Fuse States**

NVM bit 0	NVM bit 1	NVM Fuse Bit Value
Erased	Erased	Undefined
Programmed	Erased	Set (1)
Erased	Programmed	Cleared (0)
Programmed	Programmed	Undefined

The set operation changes the state in an NVM fuse from a zero to a one by programming NVM bit 0 and erasing NVM bit 1 simultaneously in the NVM fuse. This set operation can be performed without changing the contents of the CMF array.

To set one or both of the bits in CENSOR[0:1],

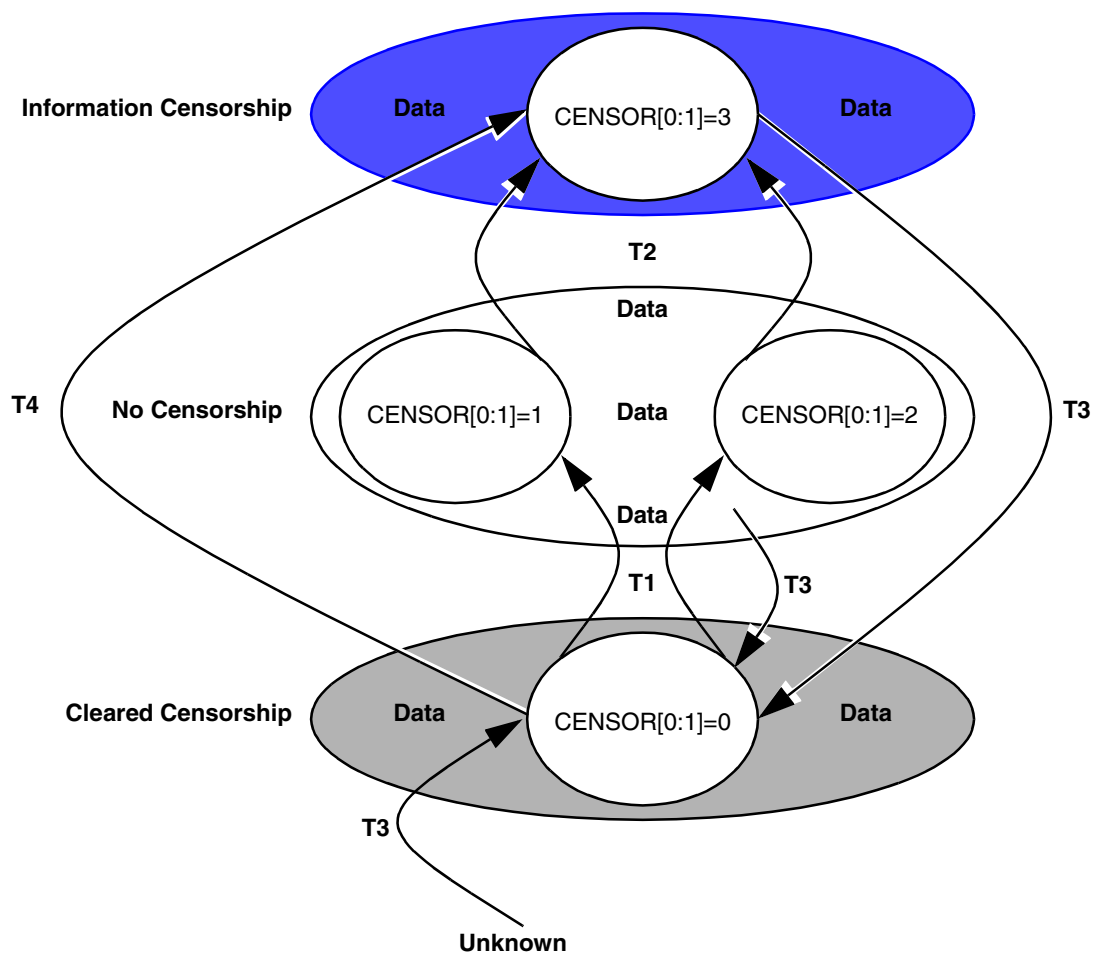
1. Using section **19.7.6 A Technique to Determine SCLKR, CLKPE, and CLKPM**, write the pulse width timing control fields for an erase pulse, CSC = 1, PE = 0 and SES = 1 in the CMFCTL register.
2. Write a one to the CENSOR bit(s) to be set.
3. Write EHV = 1 in the CMFCTL register. This will apply the programming voltages to NVM bit 0 and the erase voltages to NVM bit 1 simultaneously.
4. Read the CMFCTL register until HVS = 0.
5. Write EHV = 0 in the CMFCTL register.
6. Read the CMFMCR CENSOR bit(s) that are being set. If any bit selected for set is a 0 go to step 3.
7. Write SES = 0 and CSC = 0.

The clear operation changes the state in an NVM fuse from a one to a zero by erasing NVM bit 0 and programming NVM bit 1 simultaneously in the NVM fuse. This clear operation can be done only while erasing the entire CMF array and shadow information. To clear CENSOR[0:1],

1. Write PROTECT[0:7] = 0x00 to enable the entire array for erasure.
2. Using section **19.7.6 A Technique to Determine SCLKR, CLKPE, and CLKPM**, write the pulse width timing control fields for an erase pulse, BLOCK[0:7] = 0xFF, CSC = 1, PE = 1 and SES = 1 in the CMFCTL register.
3. Perform an erase interlock write.
4. Write EHV = 1 in the CMFCTL register. This will apply the erase voltages to the entire CMF array and NVM bit 0 and the programming voltages to NVM bit 1 simultaneously.
5. Read the CMFCTL register until HVS = 0.
6. Write EHV = 0 in the CMFCTL register.
7. Read the entire CMF array and the shadow information words. If any bit equals zero, go to step 4.
8. Read CENSOR[0:1]. If CENSOR[0:1] ≠ 0 go to step 4.
9. Write SES = 0 and CSC = 0.

### 19.8.5 Switching the CMF EEPROM Censorship

There are three levels of censorship that CENSOR[0:1] can select: cleared censorship, no censorship (two states) and information censorship. These three levels, state values, transitions and level of censorship are shown in **Figure 19-6**.



**Figure 19-6 Censorship States and Transitions**

**Figure 19-6** illustrates the following CENSOR[0:1] transitions:

- T1: Cleared censorship to no censorship  
Set CENSOR[0] or CENSOR[1].
- T2: No censorship to information censorship  
Set CENSOR[0] and CENSOR[1].
- T3: Information censorship, no censorship or unknown to cleared censorship  
clear CENSOR[0:1]. This is done only while the entire CMF array is erased.
- T4: Cleared censorship to information censorship  
Set both CENSOR[0] and CENSOR[1].

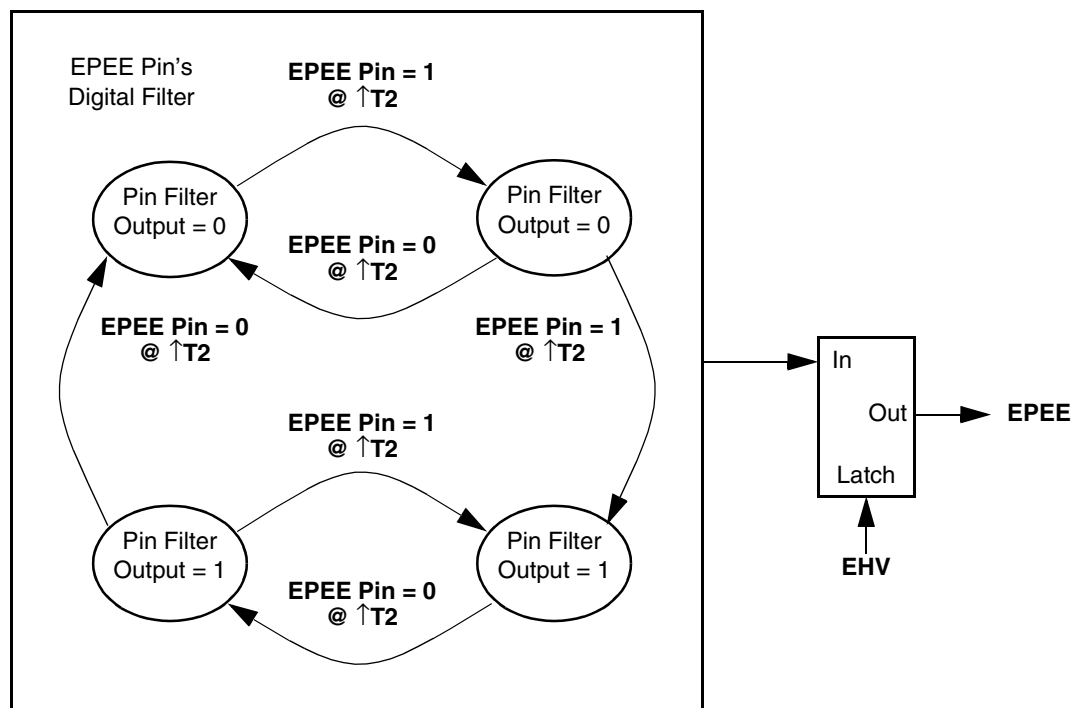
## 19.9 Pin Descriptions

The CMF modules use the following pins:

- $E_{PEE}$
- $V_{PP}$
- $V_{DDF}$
- $V_{SSF}$

### 19.9.1 $E_{PEE}$ Signal

The EPEE bit monitors the state of the external program/erase enable,  $E_{PEE}$  pin.  $E_{PEE}$  has a digital filter that requires two consecutive samples to be equal before the output of the filter changes. The CMF samples  $E_{PEE}$  when EHV is asserted and holds the  $E_{PEE}$  state until EHV is negated. This is shown in **Figure 19-7**.



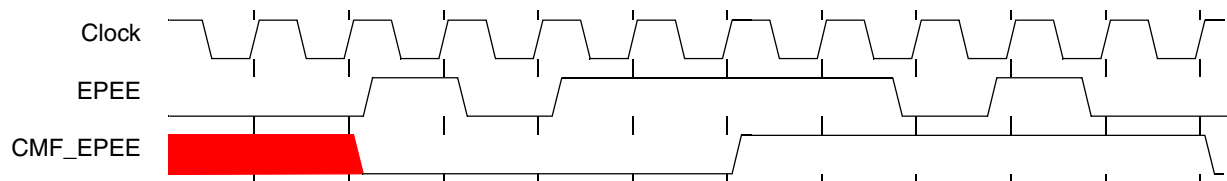
**Figure 19-7 EPEE Digital Filter and Latch**



If EPEE = 1 when EHV is asserted, high voltage operations such as program or erase are enabled. If EPEE = 0 when EHV is asserted, high voltage operations are disabled.



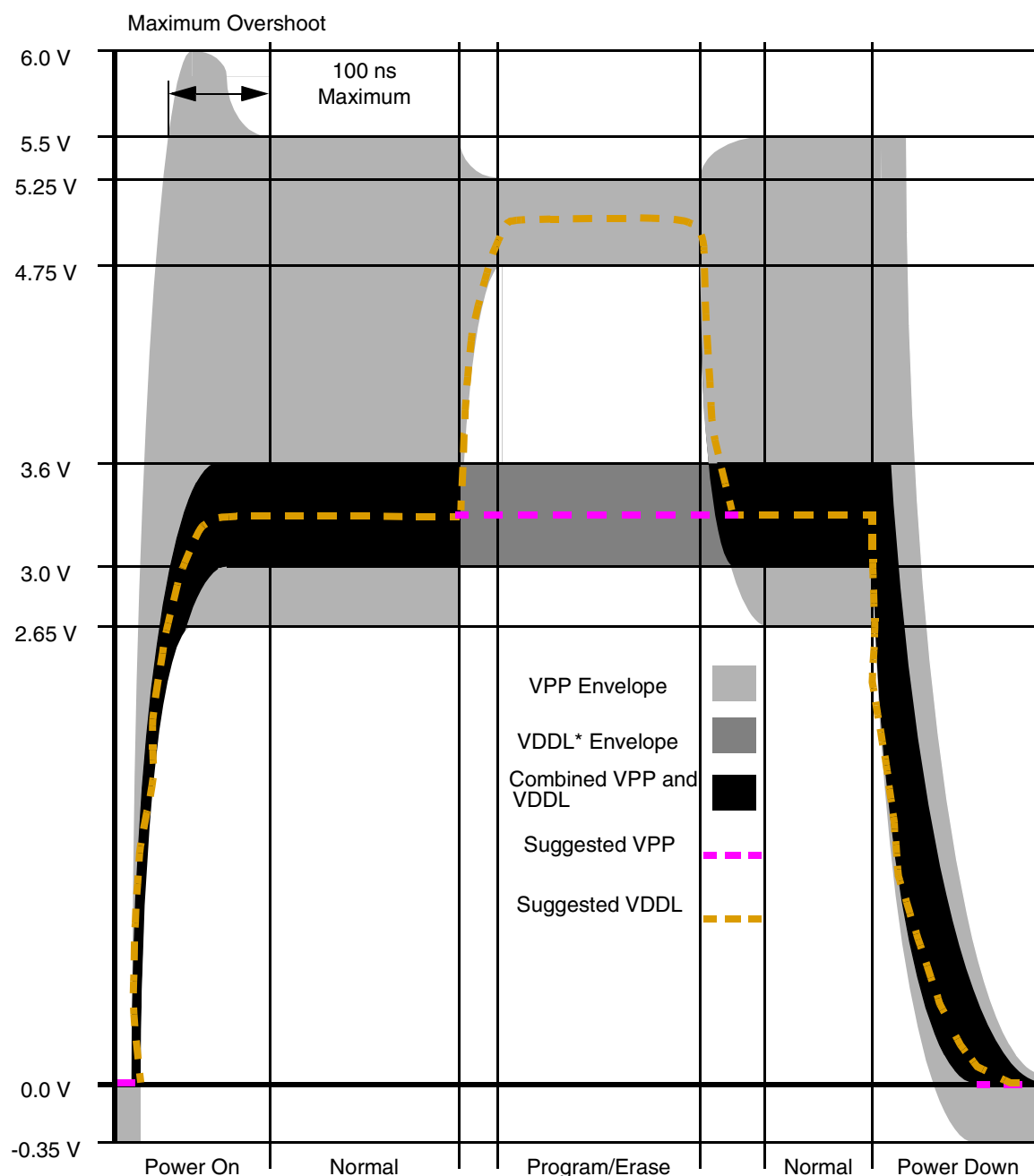
The EPEE pin uses a two-period clock synchronizer that switches the internal signal CMF\_EPEE after two consecutive constant values of EPEE, as shown in **Figure 19-8**. At first the value of CMF\_EPEE is unknown, as the prior information for the EPEE pin is not provided. One high or low clock of EPEE does not cause CMF\_EPEE to switch.



**Figure 19-8 CMF\_EPEE Timing Diagram**

### 19.9.2 FLASH Program/Erase Voltage Conditioning

A voltage of at least ( $VDDL - 0.35\text{ V}$ ) must be applied at all times to the VPP pins or damage to the FLASH module can occur. FLASH modules can be damaged by power on and power off VPP transients. VPP must not rise to programming level while VDDL is below 1.0 volts, and must not fall below the minimum specified value while VDDL is applied. **Figure 19-9** shows the VPP and VDDL operating envelope.

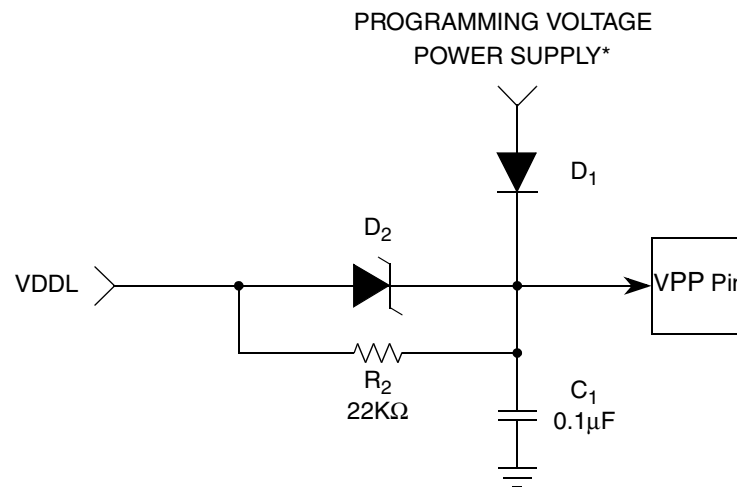


\*This assumes that VDDL = VDDI = VDDF = VDDSYN.

**Figure 19-9 VPP and VDDL Power Switching**

Use of an external circuit to condition VPP is recommended. [Figure 19-10](#) shows a simple circuit that maintains required voltages and filters transients. VPP is pulled up to VDDL via Schottky diode D2, protecting VDDL from excessive reverse current. D2 also protects the FLASH from damage should the programming voltage go to zero. Programming power supply voltage must be adjusted to compensate for the forward-

bias drop across D1. Capacitor C1 filters transients, while R2 provides a discharge bleed path for C1. Allow for RC charge and discharge time constants when applying and removing power. When using this circuit, keep leakage from external devices connected to the VPP pin low, to minimize diode voltage drop.



\*The VPP voltage specification is the voltage at the VPP pin, not the input to diode D1.

**Figure 19-10 VPP Conditioning Circuit**

## 19.10 Reset Operation

### 19.10.1 Master Reset

The MPC555 / MPC556 signals a master reset (both  $\overline{\text{PORESET}}$  or  $\overline{\text{HRESET}}$ ) to the CMF EEPROM when a full reset is required. A master reset is the highest priority operation for the CMF EEPROM and will terminate all other operations. The CMF EEPROM module uses master reset to initialize all register bits to their reset values. If the CMF EEPROM is in program or erase operation ( $\text{EHV} = 1$ ) and a master reset is generated, the module will perform the needed interlocks to disable the high voltage without damage to the high voltage circuits. Master reset will terminate any other mode of operation and force the CMF EEPROM BIU to a state ready to receive U-bus accesses within 10 clocks of the end of master reset.

If the  $\overline{\text{HC}}$  bit of the reset configuration word = 0 and the SIU requests internal configuration during reset, the CMF EEPROM will provide the reset configuration word to the device from CMFRC.

### 19.10.2 Soft Reset

A soft reset forces the BIU into a state ready to receive U-bus accesses and clear the EHV bit. All other register bits remain unaltered by a soft reset.

### 19.10.3 Emulation Operation

The CMF EEPROM supports externally mapped access for emulation operation. When the SIU indicates an externally mapped access to the CMF EEPROM, the CMF does not respond to the address, even though it may be a valid CMF access. Refer to [10.6 Dual Mapping of the Internal Flash EEPROM Array](#) for details.



### 19.11 Disabling the CMF Module

The CMF EEPROM can be disabled when the internal memories are disabled. Disabling the internal memories is controlled by the FLEN bit (bit 20) in the USIU internal memory map register. The default reset enable/disable state of the internal memories is user defined with the reset configuration word bit 20.

#### CAUTION

The reset configuration word from an erased CMF must be generated external to the CMF, i.e., from the default reset configuration word off the external reset configuration word. See [7.5 Reset Configuration](#).

EHV is reset to 0 when the CMF is disabled and can not be set until the CMF is enabled, see section [19.7.8 Controlling the Program/Erase Voltage](#). When disabled, the power used by the CMF is reduced.

#### NOTE

Although the program and erase operations can be suspended (EHV = 0) by disabling the internal memory, it is not recommended that program or erase be suspended in this manner.